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Course		Course	SE	MICONDU	CTOR I	PHYSICS AND	Cours		В			D.,	:- C ::-				I	T	P	C
Pre-		Name			IANOL	LMETHODS	Catego	ory	ъ			Das	ic Scie	nces			3		2	5
requisit	NT:			Co-			Pto	ogres	sive											
Courses				requisite	Nil		(	Cours	es	Nil										
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	Course Offering Department  Physics and Nanotechnology Codes/Standards  Nil																			
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Rationale (CLR):  The purpose of learning this course is to:								1	Program Outcomes (PO)											
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CLR-1:	Introduce ban	d gap and	Fermi level i	n semiconduct	ors and bo	nw to compute those pro	perties ·		1	2	3	4	5	6	7	8	9	10	11	12
CLR-2:	Explain the c	oncept of	carrier transp	ort mechanism	in b-n-an	ad metal semiconductor	iunction		-	-		-		+		-		10	11	12
CLR-3:	Provide an in.	sight on se	miconductor o	ptical transiti	ons and b	hotovoltaic effect	,	١.	8		b					-	Work	.	o l	1
CLR-3: Provide an insight on semiconductor optical transitions and photovoltaic effect  CLR-4: Procure knowledge of electrical and optical measurements in semiconductor and to instigate the						je Je	-	Be		ų.			.	$\bowtie$		anc				
CDIC-4.	concepts of TC	AD					8		10M	sis	lop	ď	sag	ยู			Team	1_1	E.	ing
CLR-4: Procure knowledge of electrical and optical measurements in semiconductor and to instigate the concepts of TCAD  CLR-5: Develop necessary skills for low dimensional semiconductor material processing and characterization and to introduced the basic of machine learning in image processing  CLR-6: Utilize the concepts in semiconductors physics and computational methods for the application in engineering and technology						ij	ر <del>د</del>	1	$_{\rm L}$	Communication	Project Mgt. & Finance	Long Learning								
	characterization	on and to	introduced th	e basic of maci	bine learm	ing in image processing			lig lig	Ah	Q	De	ညိ		iit		ಷ	cat	150	2
CLR-6:	Utilize the concepts in semiconductors physics and computational methods for the application in							eer	Ę	\$ 1 's	ch,	H	Society &	Environment Sustainability		Individual	in in	$\Xi$	Buc	
	engineering an	d technolo	gy						Engineering	Ple	sign	Analysis, Research	der	iet	/irc	ics	ivic	E	ject	17
							3		E	Problem	De	An	Mo	Soc	En	Ethics	[nd	18	Pro	Life
Course C	utcomes (Co	0): At i	the end of this	course, learne	rs will be	able to:														
CO-1:	Understand a	nd compu	te energy band	l in solids and	electron c	occupation probability			3	~	-	-	-	-	-	-	-	1-		-
CO-2:	Understand and analyze the working of optoelectronic devices  Apply the knowledge to the development of new and novel optoelectronic devices						3	-	-	-	-	-	-	-	-	1-				
CO-3:	Apply the kno	on ledge to	the developm	ent of new and	l novel opi	toelectronic devices			-	-	3	-	-	-	-	-	-	1-		-
CO-4:	Understand th	e working	g mechanism	of electrical an	d optical i	measurements and gain	the		3			-	-	-				1		
	fundamentals							1 L			_				-	-	-	-		•
CO-5:	Acquire know	Acquire knowledge of the low dimensional semiconductor material fabrication and characterization								3		-	-	-				1		
	and gain insign									j	-				-	-	-	-		-
CO-6:	Apply the cond	cepts ofsen	niconductors p	bysics and con	nputation	al methods in real tim	e application		3	-	3	-	1 -	1-	1 -	1-	1	1	+	

# Unit-1: ENERGY BANDS IN SOLIDS

18 Hours

Introduction to Classical Free electron theory-Introduction to Quantum Free electron theory-Density of states-Concepts-Energy band in solids-Kronig-Penney model—E-k diagram-Direct and Indirect band gap-Concept of phonons-Concept of Brillouin Zone-Computational determination of Band Structure — Concepts, Eigenvalue equations-Classification of electronic materials-Fermi level-Probability of occupation-Numerical determination of probability of occupation and carrier concentration-Concept of Fermi surface of a metal-Computational determination of Fermi Surface of Cu as example.

#### Experiments

- 1. Determination of Hall coefficient of Semiconductor material
- 2. Determination of Band Gap of semiconductor-Post Office Box method

# Unit-2: CARRIER TRANSPORT MECHANISM IN SEMICONDUCTORS

18 Hours

Intrinsic semiconductor-Dependence of Fermi level on carrier-concentration-and temperature in Intrinsic semiconductor-Extrinsic semiconductors-Dependence of Fermi level on carrier-concentration-and temperature in extrinsic semiconductors-Explanation for carrier generation-Explanation for recombination processes -Carrier transport - diffusion and drift current-Continuity equation-p-n junction-Biasing concept in p-n junction-Metal-semiconductor junction -Ohmic contact -Semiconductor materials of interest for optoelectronic devices-Photocurrent in a P-N junction diode- Light emitting diode- Classification of Light emitting diode-Optoelectronic integrated circuits-Organic light emitting diodes

## Experiments

- 3. Determination of Band Gap of semiconductor-Four probe method
- 4. Study of I-V characteristics of a light dependent resistor (LDR)
- 5. Study of V-I and V-R characteristics. Efficiency of a solar cell

### Unit-3: OPTOELECTRONIC PROPERTIES OF SEMICONDUCTORS

18 Hours

Concept of optical transitions in bulk semiconductor- Optical absorption process-Concept of recombination process-Optical recombination process-Explanation for spontaneous emission-Explanation for stimulated emission-Joint density of states in semiconductor-Density of states for photons-Explanation of transition rates-Numerical computation of optical loss-Finite element method to calculate Photon density of states -Basic concepts of Photovoltaic-Photovoltaic effect-Applications of Photovoltaic effect-Determination of efficiency of a PV cell-Computational approach to calculate optical excitations-Example; optical excitation in BN (Boron nitride)

#### Experiments

- 6. Characterization of pn junction diode (Forward and reverse bias)
- 7. Verify Inverse square law of light using a photo cell.

#### Unit-4: ELECTRICAL AND OPTICAL MEASUREMENTS

18 Hours

Concept of electrical measurements-Two point probe technique-Four point probe technique-linear method-Four point probe technique-Vander Pauw method-Significance of carrier density-Significance of resistivity and Hall mobility-Hot-point probe measurement-Capacitance-voltage measurements-Extraction of parameters in a diode-I-V characteristics of a diode-Introduction of TCAD in basic level- Significance of band gap in semiconductors-Concept of absorption and transmission-Boltzmann Transport Equation-Scattering Mechanisms-Monte Carlo method- Concept only-Example only Monte Carlo Methods for Solution of BTE( Boltzmann equation)

# Experiments

- 8. Determination of electron and hole mobility versus doping concentration using GNU Octave
- 9. Determination of Fermi function for different temperature using GNU Octave
- 10. Study of attenuation and propagation characteristic of optical fiber cable using laser source

# Unit-5: LOW DIMENSIONAL SEMICONDUCTOR MATERIALS

Density of states in 2D-Density of states in 1D and 0D-Introduction to low dimensional systems-Quantum well-Quantum wire and dots-Introduction to novel low dimensional systems -CNT- properties and synthesis-Applications of CNT-Fabrication technique-CVD-Fabrication technique-PVD-Characterizations techniques for low dimensional systems-Principle of electron microscopy-Scanning electron microscopy-Transmission electron microscopy-Atomic force microscope-Computational and machine learning approach for electron microscopy image processing - Concepts, overview-Example of Graphene

# Experiments

11. Plotting and interpretation of I-V characteristics of Diode GNU Octave

- 12. Determination of lattice parameters using powder XRD13. Mini Project

	1 J. Singh, "Semiconductor Optoelectronics": Physics and Technology, McGraw-Hill Inc.	4. A. Yariv and P. Yeb, Photonics:" Optical Electronics in Modern Communications", Oxford
	1995.	University Press, New York 2007.
Learning	2. B. E. A. Saleh and M. C. Teich, "Fundamentals of Photonics", John Wiley & Sons,	5. Computational Materials Science: An Introduction by June Gunn Lee, Chapter 7, Page 227-230 Quantum
Resources	Inc., 2007.	Espresso) and Page 300-307 (VASP)
	3. S. M. Sze, "Seniconductor Devices" Physics and Technology, Wiley 2008.	6. Finite Element Method Gouri Dhatt, Emmanuel Lefrançois, Gilbert Touzot, Wiley Publication, ISBN: 978-1-
		848-21368-5

			Continuous Learni - By the Co	By The CoE				
	Bloom's Level of Thinking	CLA-1 Aver	mative age ofunit test 5%)	CLA-	ngLearning 2- Practice 15%)	Summative FinalExamination , (40% weightage)		
		Theory	Practice	Theory	Practice	Theory	Practice	
Level 1	Remember	20	-	-	10	.20		
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Level 3	Apply	30	-	- 1	20	30	· · · · · · · · · · · · · · · · · · ·	
Level 4	Analyze	30		<b>3</b> -	40	30		
Level 5	Evaluate	•	-	-		•		
Level 6	Create	<u>-</u>	-		9 to 10 <b>-</b>			
	Total	10	0 %	10	00 %	- x • ; 1	00 %	

Course Designers		
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